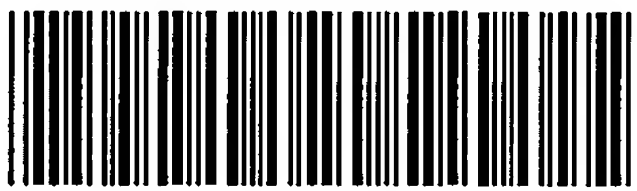




Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/625,052	CHEN ET AL.	
	Examiner	Art Unit	
	Quynh H. Nguyen	2642	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
379		433.13		455	575.3	16	250		
INTERNATIONAL CLASSIFICATION									
H	0	4	M	9/00					
				/					
				/					
				/					
				/					
Quynh H. Nguyen 1/11/06 (Assistant Examiner) (Date)					 AHMAD F. MATAR SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2700 (Primary Examiner) (Date)			Total Claims Allowed: 13	
 (Legal Instruments Examiner) 1/12/06 (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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